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74ABT20

Dual 4-input NAND gate

Rev. 3 — 12 August 2016

Product data sheet

1. General description

The 74ABT20 high-performance BiCMOS device combines low static and dynamic power dissipation with high speed and high output drive.

The 74ABT20 is a dual 4-input NAND gate.

2. Features and benefits

- Latch-up protection exceeds 500 mA per JESD78B class II level A
- ESD protection:
 - ◆ HBM JESD22-A114F exceeds 2000 V
 - MM JESD22-A115-A exceeds 200 V
- Multiple package options
- Specified from –40 °C to +85 °C

3. Ordering information

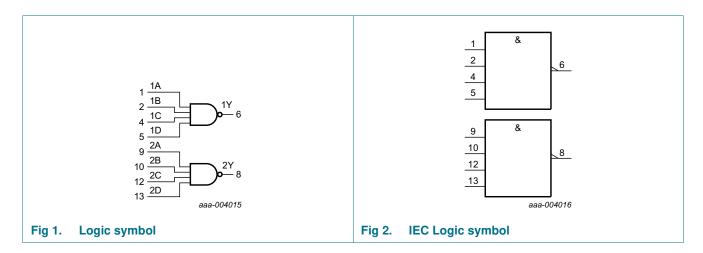
Table 1. Ordering information

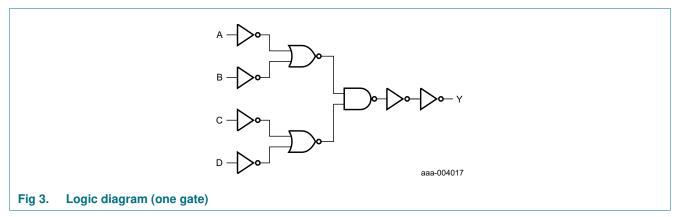
Type number	Package												
	Temperature range	Name	Description	Version									
74ABT20D	-40 °C to +85 °C	SO14	plastic small outline package; 14 leads; body width 3.9 mm	SOT108-1									
74ABT20DB	–40 °C to +85 °C	SSOP14	plastic shrink small outline package; 14 leads; body width 5.3 mm	SOT337-1									
74ABT20PW	−40 °C to +85 °C	TSSOP14	plastic thin shrink small outline package; 14 leads; body width 4.4 mm	SOT402-1									



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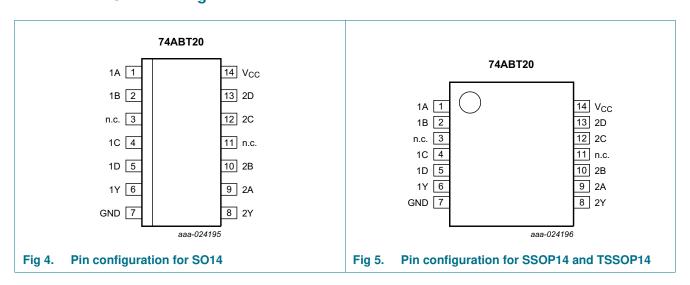
4. Functional diagram





5. Pinning information

5.1 Pinning



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5.2 Pin description

Table 2. Pin description

Symbol	Pin	Description
1A, 1B, 1C, 1D	1, 2, 4, 5	data input
n.c.	3, 11	not connected
1Y	6	data output
GND	7	ground (0 V)
2Y	8	data output
2A, 2B, 2C, 2D	9, 10, 12, 13	data input
V _{CC}	14	supply voltage

6. Functional description

Table 3. Function table[1]

Input	Input								
nA	nB	nC	nD	nY					
L	X	Х	Х	Н					
X	L	Х	Х	Н					
X	X	L	Х	Н					
X	X	Х	L	Н					
Н	Н	Н	Н	L					

^[1] H = HIGH voltage level; L = LOW voltage level; X = don't care.

7. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit
V _{CC}	supply voltage			-0.5	+7.0	V
VI	input voltage		[1]	-1.2	+7.0	V
Vo	output voltage	output HIGH or LOW	[1]	-0.5	+5.5	V
I _{IK}	input clamping current	V _I < 0 V		-18	-	mA
l _{ok}	output clamping current	V _O < 0 V		-50	-	mA
lo	output current	output in LOW-state		-	40	mA
Tj	junction temperature		[2]	-	150	°C
T _{stg}	storage temperature			-65	+150	°C

^[1] The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

^[2] The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability. The maximum junction temperature of this integrated circuit should not exceed 150 °C.

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8. Recommended operating conditions

Table 5. Operating conditions

Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _{CC}	supply voltage		4.5	-	5.5	V
VI	input voltage		0	-	V _{CC}	V
V _{IH}	HIGH-level input voltage		2.0	-	-	V
V _{IL}	LOW-level input voltage		-	-	0.8	V
I _{OH}	HIGH-level output current		-15	-	-	mA
I _{OL}	LOW-level output current		-	-	20	mA
Δt/ΔV	input transition rise and fall rate		0	-	5	ns/V
T _{amb}	ambient temperature	in free air	-40	-	+85	°C

9. Static characteristics

Table 6. Static characteristics

Symbol	Parameter	Conditions			25 °C		–40 °C t	o +85 °C	Unit
								Max	
V _{IK}	input clamping voltage	$V_{CC} = 4.5 \text{ V}; I_{IK} = -18 \text{ mA}$		-1.2	-0.9	-	-1.2	-	٧
V _{OH}	HIGH-level output voltage	$V_{CC} = 4.5 \text{ V}; I_{OH} = -15 \text{ mA};$ $V_I = V_{IL} \text{ or } V_{IH}$		2.5	2.9	-	2.5	-	V
V _{OL}	LOW-level output voltage	V_{CC} = 4.5 V; I_{OL} = 20 mA; V_I = V_{IL} or V_{IH}		-	0.35	0.5	-	0.5	V
I _I	input leakage current	V _{CC} = 5.5 V; V _I = GND or 5.5 V		-	±0.01	±1.0	-	±1.0	μΑ
I _{OFF}	power-off leakage current	$V_{CC} = 0 \text{ V}; V_1 \text{ or } V_O \le 4.5 \text{ V}$		-	±5.0	±100	-	±100	μΑ
I _{CEX}	output high leakage current	HIGH-state; $V_O = 5.5 \text{ V}$; $V_{CC} = 5.5 \text{ V}$; $V_I = GND \text{ or } V_{CC}$		-	5.0	50	-	50	μΑ
Io	output current	$V_{CC} = 5.5 \text{ V}; V_{O} = 2.5 \text{ V}$	<u>[1]</u>	-50	-75	-180	-50	-180	mA
I _{CC}	supply current	$V_{CC} = 5.5 \text{ V}; V_I = \text{GND or } V_{CC}$		-	2	50	-	50	μΑ
Δl _{CC}	additional supply current	per input pin; V _{CC} = 5.5 V; one input at 3.4 V; other inputs at V _{CC} or GND	[2]	-	0.25	500	-	500	μΑ
C _I	input capacitance	V _I = 0 V or V _{CC}		-	3	-	-	-	pF

^[1] Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

^[2] This is the increase in supply current for each input at 3.4 V.

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10. Dynamic characteristics

Table 7. Dynamic characteristics

GND = 0 V; for test circuit, see Figure 7.

Symbol	Parameter	Conditions	25 °C	; V _{CC} =	5.0 V	-40 °C to V _{CC} = 5.0	Unit	
			Min	Тур	Max	Min	Max	
t _{PLH}	LOW to HIGH propagation delay	nA, nB, nC, nD to nY; see Figure 6	1.0	2.7	3.9	1.0	4.6	ns
t _{PHL}	HIGH to LOW propagation delay	nA, nB, nC, nD to nY; see Figure 6	1.0	2.2	3.4	1.0	3.8	ns
t _{sk(o)}	output skew time	[1]	-	0.3	0.5	-	0.5	ns

^[1] Skew between any two outputs of the same package switching in the same direction. This parameter is guaranteed by design.

11. Waveforms

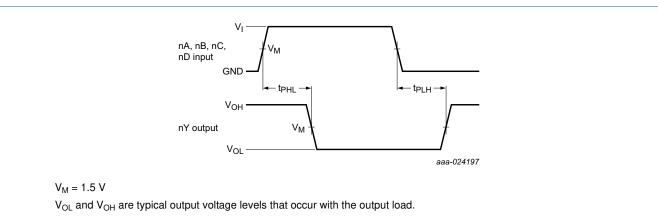
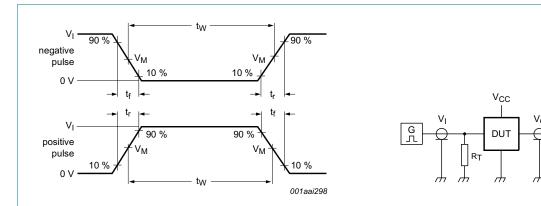


Fig 6. Propagation delay input (nA, nB, nC, nD) to output (nY) and output skew time

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mna616



a. Input pulse definition

Test data is given in Table 8.

 R_L = Load resistance.

 C_L = Load capacitance including jig and probe capacitance.

 R_T = Termination resistance should be equal to output impedance Z_o of the pulse generator.

 V_{EXT} = External voltage for measuring switching times.

Fig 7. Test circuit for measuring switching times

Table 8. Test data

Input			Load	V _{EXT}		
V _I	f _i	t _W	t _r , t _f	CL	RL	t _{PHL} , t _{PLH}
3.0 V	1 MHz	500 ns	≤ 2.5 ns	50 pF	500 Ω	open

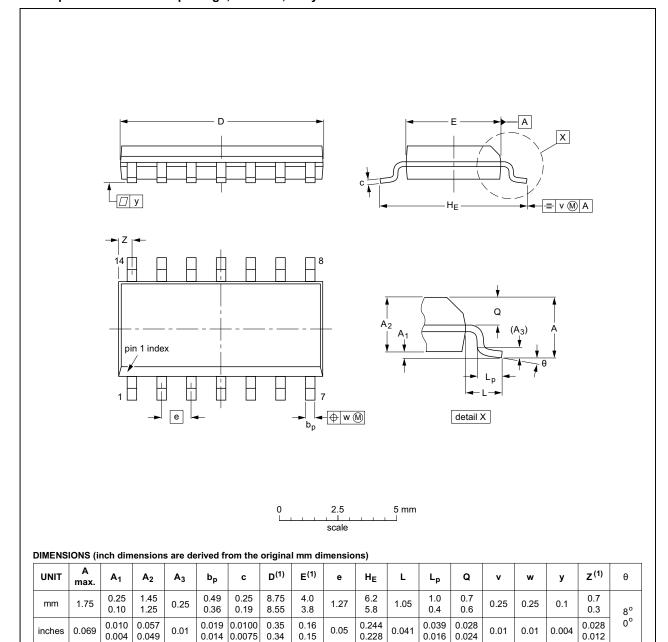
b. Test circuit

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12. Package outline

SO14: plastic small outline package; 14 leads; body width 3.9 mm

SOT108-1



Note

1. Plastic or metal protrusions of 0.15 mm (0.006 inch) maximum per side are not included.

OUTLINE		REFER	RENCES	EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	JEITA	PROJECTION	ISSUE DATE
SOT108-1	076E06	MS-012			99-12-27 03-02-19

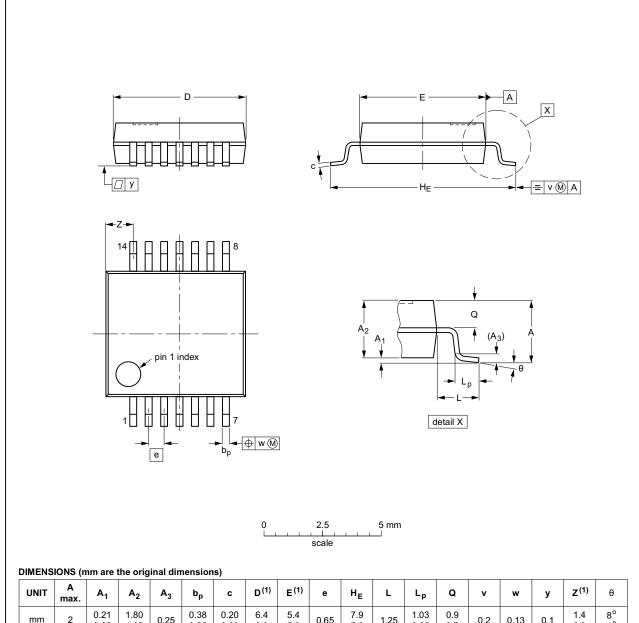
Fig 8. Package outline SOT108-1 (SO14)

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SSOP14: plastic shrink small outline package; 14 leads; body width 5.3 mm

SOT337-1



UNIT	A max.	A ₁	A ₂	A ₃	b _p	U	D ⁽¹⁾	E ⁽¹⁾	e	HE	L	Lp	Q	>	w	у	Z ⁽¹⁾	θ
mm	2	0.21 0.05	1.80 1.65	0.25	0.38 0.25	0.20 0.09	6.4 6.0	5.4 5.2	0.65	7.9 7.6	1.25	1.03 0.63	0.9 0.7	0.2	0.13	0.1	1.4 0.9	8° 0°

Note

1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

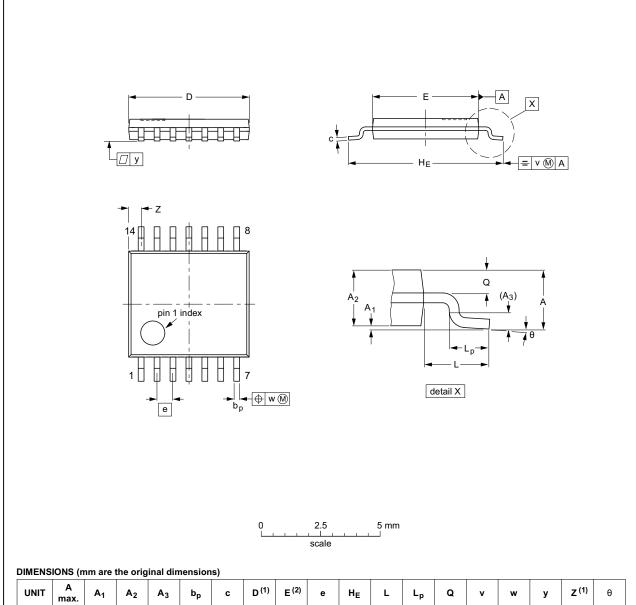
JEDEC	JEITA	PROJEC	TION ISSUE DATE
MO-150			99-12-27 03-02-19
	MO-150	MO-150	MO-150

Package outline SOT337-1 (SSOP14) Fig 9.

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TSSOP14: plastic thin shrink small outline package; 14 leads; body width 4.4 mm

SOT402-1



UNIT	A max.	A ₁	A ₂	A ₃	b _p	С	D ⁽¹⁾	E (2)	е	HE	L	Lp	Q	٧	w	у	Z ⁽¹⁾	θ
mm	1.1	0.15 0.05	0.95 0.80	0.25	0.30 0.19	0.2 0.1	5.1 4.9	4.5 4.3	0.65	6.6 6.2	1	0.75 0.50	0.4 0.3	0.2	0.13	0.1	0.72 0.38	8° 0°

Notes

- 1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
- 2. Plastic interlead protrusions of 0.25 mm maximum per side are not included.

OUTLINE	REFERENCES				EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE
SOT402-1		MO-153				99-12-27 03-02-18
						03-02

Fig 10. Package outline SOT402-1 (TSSOP14)

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13. Abbreviations

Table 9. Abbreviations

Acronym	Description
BiCMOS	Bipolar Complementary Metal-Oxide Semiconductor
DUT	Device Under Test
ESD	ElectroStatic Discharge
HBM	Human Body Model
MM	Machine Model

14. Revision history

Table 10. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
74ABT20 v.3	20160812	Product data sheet	-	74ABT20 v.2
Modifications:	The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors.			
	 Legal texts ha 	ve been adapted to the new c	ompany name where	e appropriate.
74ABT20 v.2	19950918	Product specification	-	-

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15.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
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